

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/644,735	PARK ET AL.
	Examiner	Art Unit
	TRONG PHAN	2827

## **Search Notes**



**Application/Control No.**

10/644,735

Examiner

TRONG PHAN

**Applicant(s)/Patent under  
Reexamination**

PARK ET AL.

## **Art Unit**

2827

**SEARCHED**

**SEARCHED**

## **INTERFERENCE SEARCHED**

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Class	Subclass	Date	Examiner